

Search Notes

Application/Control No.

10/807,764

Examiner

Khanh V. Nguyen

Applicant(s)/Patent under
Reexamination

DOW ET AL.

Art Unit

2817

SEARCHED			
Class	Subclass	Date	Examiner
330	51	8/8/2005	NKV
330	129		
330	133		
330	302		
330	303		
330	306		
330	310		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner